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High-resolution Faraday rotation and electron phonon coupling in surface states of bulk-insulating topological insulator Cu_{0.02}Bi₂Se₃

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We have utilized time-domain magneto-terahertz spectroscopy to investigate the low frequency optical response of topological insulator $Cu_{0.02}Bi_2Se_3$ and Bi_2Se_3 films. With both field and frequency dependence, such experiments give sufficient information to measure the mobility and carrier density of multiple conduction channels simultaneously. We observe sharp cyclotron resonances (CRs) in both materials. The small amount of Cu incorporated into the $Cu_{0.02}Bi_2Se_3$ induces a true bulk insulator with only a *single* type of conduction with total sheet carrier density ~ 4.9×10^{12} /cm² and mobility as high as 4000 cm²/V·s. This is consistent with conduction from two virtually identical topological surface states (TSSs) on top and bottom of the film with a chemical potential ~145 meV above the Dirac point and in the bulk gap. The CR broadens at high fields, an effect that we attribute to an electron-phonon interaction. This assignment is supported by an extended Drude model analysis of the zero field Drude conductance. In contrast, in normal Bi_2Se_3 films two conduction channels were observed and we developed a self-consistent analysis method to distinguish the dominant TSSs and coexisting trivial bulk/2DEG states. Our high-resolution Faraday rotation spectroscopy on $Cu_{0.02}Bi_2Se_3$ paves the way for the observation of quantized Faraday rotation under experimentally achievable conditions to push chemical potential in the lowest Landau Level.

Topological insulators (TIs) are a newly discovered class of materials characterized by an inverted band structure [1, 2] caused by strong spin-orbit coupling. In the ideal case, they have an insulating bulk and only conduct via topologically protected massless Dirac topological surface states (TSSs). Spin-momentum locking in their electronic structure makes TIs promising platforms for spintronics applications [3]. Progress in this field has been hampered by the fact that all discovered TIs to date are slightly doped and have a conducting bulk. For instance, the proposed topological magneto-electric effect [4] and quantized Faraday rotation [5] remains unobserved. Tuning the chemical potential towards the Dirac point and enhancing mobility was shown to be very successful in probing many-body interactions with plasmons and phonons in graphene [6] and similar advancements are expected in TIs, but have not yet been realized.

The band structure of Bi₂Se₃ is one of the simplest of the 3D TIs with only a single Dirac cone at the center of the Brillouin zone. Unfortunately, native grown Bi₂Se₃ is known to have a conducting bulk due to defects from the growth. Suppression of the bulk carrier density has been achieved by chemical doping methods [7, 8]. Nevertheless, these samples still have significant densities of bulk carriers or impurity states that are pinned near E_{*F*}. Recently it was found that $\sim 2\%$ Cu doping in thin films suppresses the bulk carriers and allows a true insulating state to be realized [9]. Here we investigate these copper doped bulk insulating thin films and their decoupled TSSs [9] via magneto-terahertz spectroscopy. These films were capped by a thin insulating amorphous Se layer. Details of the growth can be found in the supplement

tary information (SI) section I [10] and in Ref. [9].

Cyclotron resonance (CR) experiments using THz spectroscopy are a powerful tool to study Dirac fermions and probe many-body interactions [11, 12]. CR is also one of the most accurate measures of effective mass [13]. In previous work, a large Kerr rotation in bulk-conducting Bi_2Se_3 films was reported, but no obvious resonance was observed [14]. Cyclotron resonance has been reported in In_2Se_3 capped films [15], but current understanding is that significant Indium diffusion from In_2Se_3 to Bi_2Se_3 [16] destroys the simple non-TI/TI boundary at the interface, as a topological phase transition occurs at low Indium concentrations (~ 6%) [17].

In the present work, we used time-domain magnetoterahertz spectroscopy with the polarization modulation technique [18] (0.5mrad resolution, see SI section I for experimental details [10]) to observe sharp cyclotron resonances in Faraday rotations from both Cu_{0.02}Bi₂Se₃ and pure Bi₂Se₃ thin films. We demonstrate that Cu_{0.02}Bi₂Se₃ can be described by a single Drude component with total carrier density $n_{2D} \sim 4.9 \times 10^{12} / \text{cm}^2$. This Drude contribution is consistent with pure surface state transport with an $E_F \sim 145 \text{ meV}$ above the Dirac point (75 meV below the conduction band edge), which makes Cu_{0.02}Bi₂Se₃ a true topological insulator. CR broadening at high field is attributed to an electron phonon interaction. In contrast, we find two channel conduction in pure Bi₂Se₃ films. We determine that the large Faraday rotation is induced by a dominant high-mobility TSSs channel with an $E_F \sim 350$ meV. However, a weaker low-mobility second Drude term is also required to fit the data. This subdominant term most likely derives from trivial states (bulk and/or

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FIG. 1: (Color online) Data summary for 64 QL Cu_{0.02}Bi₂Se₃ (sample1). (a) Real sheet conductance of 64 QL Cu_{0.02}Bi₂Se₃ and pure Bi₂Se₃ films at 5K. Inset is the Drude conductance G_D of 64 QL Cu_{0.02}Bi₂Se₃ after subtracting the phonon and ϵ_{∞} contributions. The arrow indicates the deviation from pure Lorentzian form that arises from electron-phonon coupling. (b) Field dependent conductance at 5K. Arrows are guides to the eye for cyclotron frequencies. (c) Real and (d) Imaginary parts of the complex Faraday rotation data at different fields at 5K. (e) Cyclotron frequency versus field. Solid line is a linear fit. The inset is a cartoon indicating $E_F \sim 145$ meV above the Dirac point (75 meV below conduction band minimum). (f) Complex Faraday angle with fits at 7 T. The solid curve is a fit with a field-dependent scattering rate. Arrows are guides to the eye for cyclotron frequency is a fit using the zero-field scattering rate. Arrows are guides to the eye for cyclotron frequency.

2DEG).

In Fig. 1(a), we compare the zero field THz conductance of a 64 QL Cu_{0.02}Bi₂Se₃ film to a pure 64 QL Bi₂Se₃ film. The Cu incorporated sample's spectra are characterized by a reduced total spectral weight and slightly lower scattering rate than the pure Bi₂Se₃. The spectra can be well fit by an oscillator model with only a Drude term describing free electronlike motion, a Drude-Lorentz term modeling the phonon and a lattice polarizability ϵ_{∞} term that originates from absorptions above the measured spectral range.

$$G(\omega) = \epsilon_0 d \left(-\frac{\omega_{pD}^2}{i\omega - \Gamma_D} - \frac{i\omega\omega_{pDL}^2}{\omega_{DL}^2 - \omega^2 - i\omega\Gamma_{DL}} - i(\epsilon_\infty - 1)\omega \right) \quad (1)$$

Here Γ 's are scattering rates, ω_p 's are plasma frequencies, and d is the film thickness. The spectral weight $(\omega_{pD}^2 d)$ is pro-

portional to the integrated area of each feature in the real part of the conductance. It gives the ratio of carrier density to an effective transport mass.

$$\frac{2}{\pi\epsilon_0}\int G_{D1}d\omega = \omega_{pD}^2 d = \frac{n_{2D}e^2}{m^*\epsilon_0}$$
(2)

Here m^* is defined as $\hbar k_F / v_F$ for "massless Dirac fermions". Considering the TSS dispersion up to quadratic corrections $E = Ak_F + Bk_F^2$, the spectral weight can be expressed in terms of k_F , where A and B are parameters obtained from ARPES (see SI section II [10]).

$$\omega_{pD}^{2}d = \frac{k_{F}(A+2Bk_{F})e^{2}}{2\pi\hbar^{2}\epsilon_{0}}$$
(3)

This expression assumes the single channel conduction originates in two nominally identical TSSs. From the spectral weight analysis, having determined k_F , we can then calculate both n_{2D} (proportional to k_F^2) and m^{*}. From these Drude-Lorentz fits, we find a *total* sheet carrier density $n_{2D} \sim 5.0$ $\times 10^{12}/\text{cm}^2$, $m^* \sim 0.14 m_e$, and $E_F \sim 145 (\pm 5)$ meV according to Eq.3.

We can estimate the carrier density and mass by the zero field spectra alone because both can be expressed as a function of k_F . Below we determine the mass in a model free fashion through CR experiments. The signature of CR is a peak in the real part of the conductance (Fig. 1(b)), an inflection point in real part of Faraday rotation θ'_{F} (Fig. 1(c)) and a dip in the imaginary part of Faraday rotation $\theta_F^{''}$ (Fig. 1(d)). Its full width at half maximum (FWHM) is the scattering rate. Field dependent complex Faraday rotation data are shown in Fig. 1(c)(d). One can see that an edge feature around an inflection point in θ'_F and a dip in θ''_F shifts to higher frequency with increasing field, which is consistent with CR. We fit the data by a Drude-Lorentz model accounting for the field dependence of the Drude term and constraining the parameters of the phonon and ϵ_{∞} by the values extracted from the zerofield conductance fits. The conductance in a magnetic field can be described by the expression:

$$G_{\pm} = -i\epsilon_0 \omega d \left(\frac{\omega_{pD}^2}{-\omega^2 - i\Gamma_D \omega \mp \omega_c \omega} + \frac{\omega_{pDL}^2}{\omega_{DL}^2 - \omega^2 - i\omega\Gamma_{DL}} + (\epsilon_{\infty} - 1) \right)$$
(4)

Here the \pm sign signifies the response to right/left-hand circularly polarized light, respectively. ω_c is the CR frequency to be defined below. The Faraday rotation can be expressed as $\tan(\theta_F) = -i(t_+ - t_-)/(t_+ + t_-)$ [19]. Note that the Faraday equation is a complex quantity because, in addition to rotations, phase shifts that are different for right/left-hand polarized light can be accumulated. The imaginary part is related to the ellipticity [18].

The fits to this model for the Faraday rotation are shown for a representative field of 7 T in Fig. 1(f) (see SI section II for fits to all fields [10]). In this plot, the dashed curves are from a fit with the spectral weight and scattering rate ~ 0.4 THz set by the zero-field conductance fit (e.g. only ω_c allowed to vary). One can see that although the gross features of the spectra are reproduced, using the zero field scattering rate entirety fails to reproduce certain aspects of the Faraday rotation, including the value of the minimum in θ''_{F} . A much better fit (solid line) can be obtained by letting the scattering rate vary with field, while keeping other parameters (except for ω_c) fixed. The origin of this field dependent scattering rate will be addressed below. The fits allow us to extract the cyclotron frequency as a function of field; it is exhibited by the raw spectra as the minimum in θ_F'' . As shown in Fig. 1(e), a linear fitting using the expected relation between mass and the resonance frequency $\omega_c = eB/2\pi m^*$ gives an effective mass of 0.14 m_e . By using Eq. 2 and spectral weight obtained from fitting Faraday rotation, we can extract a total sheet carrier density $n_{2D} = 4.9 \pm 0.1 \times 10^{12} / \text{cm}^2$. With the known band structure of Bi₂Se₃, this charge density, and the observation of a single kind of charge carrier is only consistent with two essentially identical TSSs and an $E_F \sim 145$ meV above the Dirac point. We can conclude that Cu_{0.02}Bi₂Se₃ has an insulating bulk and for the sample highlighted here a high mobility $\mu = e/2\pi\Gamma_D m^* \sim 4000 \text{ cm}^2/\text{V} \cdot \text{ s.}$ The features were robust to sample aging as the samples (with the amorphous Se cap) maintain bulk-insulating and high mobility after sitting in air for eight months (see SI section II [10]).

Films of $Cu_{0.02}Bi_2Se_3$ can be contrasted with films of pure Bi_2Se_3 , which is known to have the surface chemical potential pinned in the bulk conduction band [20, 21]. We develop a self-consistent data analysis method and use our high-resolution magneto-terahertz spectroscopy to precisely determine the contribution of the subdominant bulk. In Fig. 2(a), we show zero field conductance spectra from a typical 100 QL Bi_2Se_3 film. It has higher spectral weight than $Cu_{0.02}Bi_2Se_3$, consistent with a higher charge density. For the same reason, the plateau-like Faraday rotation at 7 T at low frequencies in Fig. 2(f) is as large as ~0.25 radians while the value for the $Cu_{0.02}Bi_2Se_3$ sample is ~0.07 radians.

In Figs. 2(b)-(d), one can see that the CR is exhibited at lower frequencies, which indicates that Bi2Se3 has a higher CR mass. In Fig. 2(e), the linear fit of ω_c vs. B gives an effective mass ~0.20 m_e . We believe that this derives from TSSs, as this mass is inconsistent with the accepted values for the bulk bands[22] or band bending induced surface 2DEG bands [23]. Note that the value of CR mass in Bi₂Se₃ we determine here is different than that given in our previous work [14]. The reason for this discrepancy is discussed at length in the SI section VI [10].

One can see from Fig. 2(f) that fits of the Faraday rotation using only a single Drude term are reasonably good. As before we use the spectral weight and CR mass by Eq. 2 to extract a total sheet carrier density $n_{2D} \sim 1.9 \pm 0.1 \times 10^{13}$ /cm². This compares favorably to a density of $n_{2D} \sim 2.0 \times 10^{13}$ /cm², a mass of ~0.20 m_e , and an $E_F \sim 350$ meV that we can determine purely from an analysis of the spectral weight using the TSS dispersion by Eq. 3. We determine a mobility of $\mu \sim 3200$ cm²/V· s of the TSSs.

However, while the fits to the Faraday rotation with a single Drude term are excellent, significant discrepancies arise



FIG. 2: (Color online) (a) Real conductance of 100 QL Bi₂Se₃ comparing single and two component Drude fits as detailed in text. The inset enlarges the low frequency regime. (b) Field dependent conductance at 5K. (c) The real and (d) imaginary parts of the complex Faraday rotation data at different fields at 5K. (e) The cyclotron resonance frequency versus field. The inset is a cartoon indicating $E_F \sim$ 350 meV above the Dirac point. (f) Complex Faraday rotation data with one and two component Drude fits at 7 T. The dashed and solid curves are one and two Drude fits respectively.

if we use the resulting parameters to fit the conductance data. In Fig. 2(a), one can see that the single Drude component fit significantly underestimates the conductance by a roughly constant amount over the entire spectral range. As E_F is in the bottom of the conduction band, it is reasonable to ascribe this difference to a subdominant low mobility conduction channel originating in bulk or 2DEG. Adding a second term with a large scattering rate ($\Gamma > 4$ THz such that the contribution to the real conductance is a constant offset) improves the conductance fit dramatically. If literature values for the bulk or 2DEG mass are used, this channel has carrier density $n_{2D} \sim$ 8.0×10^{12} /cm² and low mobility $\mu < 300$ cm²/V·s. The second flat Drude term only adds a featureless small background to the Faraday rotation. The ratio $G_{1TSSs}/G_{1total} \ge 90\%$ at low frequencies confirms that TSSs dominate transport as inferred in previous THz measurements [14, 17].

Having identified the transport channels in these films and their relevant parameters, we can look in more detail at the magnetic field dependence of the scattering rates. As shown in Fig. 3(a) the scattering rate Γ_D in Cu_{0.02}Bi₂Se₃ increases with cyclotron frequency/field, displaying a maximum near a cyclotron frequency of 0.9 THz \pm 0.1 THz. As discussed



FIG. 3: (Color online) (a) Scattering rate as a function of cyclotron frequency (red). Fully renormalized scattering rate by mass through extended Drude analysis as a function of frequency (green). Black arrow indicates β surface phonon frequency at Kohn anomaly. (b) Renormalized mass as a function of frequency. The error bars express the uncertainty in ω_{pD} .

in the SI section III [10], we can exclude magnetic field induced spin- or orbital-based electronic mechanisms for this broadening [24]. We plot the scattering rate vs. the cyclotron frequency instead of vs. the magnetic field in order to allow a direct comparison with the measurement and phonon frequencies. One can understand magnetic field as a energy sampling process as following. With increasing field, the Drude peak center frequency ω_c shifts to higher energies. As the Drude peak overlaps with the phonon frequency, one expects the scattering rate to reach its maximum value and saturate as one generally expects that the CR will become broader at frequencies above the relevant phonon frequency because new scattering channels emerge. Similar CR broadening has been observed in GaInAs quantum wells and graphene and ascribed to electron-phonon coupling[25, 26].

An extended Drude model (EDM) analysis [27] of the *zero field* Drude conductance supports the inference that the broadening is due to coupling to a low energy mode such as a phonon. Such analysis allows one to quantify subtle deviations from pure Drude behavior (e.g s. pure Lorentzian form) as shown in Fig. 1(a) inset in the form of frequency dependent mass renormalizations $m_{RN}^*(\omega)$ and scattering rates $\Gamma_D(\omega)$ shown in Fig.3. In such analysis one inverts the Drude intraband contribution to the conductance (G_D) via Eqs. 5.

$$\Gamma_D(\omega) = \frac{1}{2\pi\tau(\omega)} = \frac{\omega_{pD}^2 d}{2} \operatorname{Re}(\frac{1}{G_D}), \quad \frac{m_{RN}^*(\omega)}{m_b} = -\frac{\omega_{pD}^2 d}{2\omega} \operatorname{Im}(\frac{1}{G_D})$$
(5)

Here m_b is the band mass without interaction renormalization. An EDM analysis shows a frequency dependent scattering rate $\Gamma_D(\omega)$ and an electron-phonon coupling constant $(\lambda = \frac{m_{RN}^*}{m_b} - 1)$ defined at DC limit ~ 0.55 ± 0.05. Since the mass renormalization here is reasonably small, we approximate the bare plasma frequency with the value extracted from zero-field conductance or CR fits.

From the EDM parameters we can define the "fully renormalized" scattering rate $\Gamma_D^*(\omega) = \frac{\Gamma_D(\omega)}{m_{RN}^*(\omega)/m_b}$ which is manifested as the actual width of the low frequency Drude feature (e.g. the Γ_D of Eq. 4)[28]. Plotting this quantity in Fig. 3(a), we find the general trend and energy scales of the scattering rate from the EDM are about the same as those from the CR fit. One can see that the result from EDM is a sharper version of the curve from the CR fit, which may be expected because the CR fit assumed a frequency independent scattering rate, and as such means it is an average over a (weakly) frequency dependent quantity.

For the first time we have demonstrated a correspondence between the spectral features in a CR experiment and EDM analyses, which indicates the magnetic field itself is not the source of the CR broadening. We propose electron-phonon coupling as cause of these effects [29–32] as the energy scale of the threshold in the scattering rate matches that of a number of electron-phonon scales in this system. The value is close to the scale of the previously observed Kohn anomaly of the surface β phonon, 0.75 THz at $2k_F$ [30] [33]. It also matches closely the scale of the maximum acoustic phonon energy that can couple to cross Fermi surface scattering c $\times 2k_F/2\pi \sim 0.6$ THz (where c is the acoustic phonon velocity) [31]. The coupling strength λ extracted by EDM is close to the value $\lambda \sim 0.43$ by analysis of the Kohn anomaly [34], and also agrees with calculation $\lambda \sim 0.42$ for acoustic phonons in thin film geometry[32]. The coupling constant we observed is within the different values ARPES give[35–37]. The energy scale of the 3 meV mode found via ARPES in Ref.[37] agrees well with the characteristic energy here. The lower coupling strength we observed may be due to the lower chemical potential of our sample than that used in Ref.[37].

Looking forward our results demonstrate the possibility of observing a quantized Faraday rotation in such films of a TI. For the quantized Faraday rotation of a film on a substrate one has $\tan(\theta_F) = \frac{2\alpha}{1+n}(\nu + 1/2) \sim 3.5mrad(\nu + 1/2)$ for each surface state in the quantum regime, where α is the fine structure constant, v is the filling factor and n is the substrate index of refraction. The Landau level spectrum will be $E(\pm v) = \pm v_F \sqrt{2e\hbar B |v|}$. In order to reach the lowest LL in this true topological insulator $Cu_{0.02}Bi_2Se_3$ will require 150T, which may be achievable for future THz experiments at pulse field facilities. Electric field gating the present samples in a THz compatible arrangement would bring down this field threshold. We hope our high-resolution Faraday rotation spectroscopy will enable the observation of the long-sought quantized Faraday rotation and topological magneto-electric effect[4, 5].

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- [1] M. Z. Hasan and C. L. Kane, Rev. Mod. Phys. 82, 3045 (2010).
- [2] X.-L. Qi and S.-C. Zhang, Rev. Mod. Phys. 83, 1057 (2011).
- [3] D. Pesin and A. H. MacDonald, Nat. Mat. 11, 409 (2012).
- [4] X.-L. Qi, T. L. Hughes, and S.-C. Zhang, Phys. Rev. B 78, 195424 (2008).
- [5] W.-K. Tse and A. H. MacDonald, Phys. Rev. Lett. 105, 057401 (2010).
- [6] D. Basov, M. Fogler, A. Lanzara, F. Wang, and Y. Zhang, Reviews of Modern Physics 86, 959 (2014).
- [7] Z. Ren, A. A. Taskin, S. Sasaki, K. Segawa, and Y. Ando, Phys. Rev. B 82, 241306 (2010).
- [8] J. Xiong, A. Petersen, D. Qu, Y. Hor, R. Cava, and N. Ong, Physica E 44, 917 (2012).
- [9] M. Brahlek, N. Koirala, M. Salehi, N. Bansal, and S. Oh, Phys. Rev. Lett. 113, 026801 (2014).
- [10] See Supplemental Material [url], which includes Refs. [38-47].
- [11] I. Crassee, J. Levallois, A. Walter, M. Ostler, A. Bostwick, E. Rotenberg, T. Seyller, D. Van Der Marel, and A. Kuzmenko, Nature Physics 7, 48 (2010).
- [12] Z. Jiang, E. A. Henriksen, L. C. Tung, Y.-J. Wang, M. E. Schwartz, M. Y. Han, P. Kim, and H. L. Stormer, Phys. Rev. Lett. 98, 197403 (2007).
- [13] J. Kono and N. Miura, High Magnetic Fields: Science and Technology, Volume III, World Scientific, Singapore (2006).
- [14] R. Valdés Aguilar, A. V. Stier, W. Liu, L. S. Bilbro, D. K. George, N. Bansal, L. Wu, J. Cerne, A. G. Markelz, S. Oh, et al., Phys. Rev. Lett. 108, 087403 (2012).
- [15] G. S. Jenkins, D. C. Schmadel, A. B. Sushkov, H. D. Drew, M. Bichler, G. Koblmueller, M. Brahlek, N. Bansal, and S. Oh, Phys. Rev. B 87, 155126 (2013).
- [16] H. Lee, C. Xu, S. Shubeita, M. Brahlek, N. Koirala, S. Oh, and T. Gustafsson, Thin Solid Films 556, 322 (2014).
- [17] L. Wu, M. Brahlek, R. V. Aguilar, A. V. Stier, C. M. Morris, Y. Lubashevsky, L. S. Bilbro, N. Bansal, S. Oh, and N. P. Armitage, Nature Physics 9, 410 (2013).
- [18] C. Morris, R. Valdés Aguilar, A. Stier, and N. Armitage, Optics Express 20, 12303 (2012).
- [19] The transmission can be analyzed according to the thin film transmission equation for each polarization handedness separately. t_{\pm} is the transmission for right/left-hand circularly polarized light. $t_{\pm} = t_{vs}e^{i\phi_s}t_{sfv\pm}$ is the transmission for right/left hand circularly polarized light, where t_{vs} is the transmission from vacuum to substrate $t_{vs} = 2/(1 + n_s)$, $t_{sfv\pm}$ is the transmission from substrate thought film then to vacuum $t_{sfv\pm} = 2n_s/(1 + n_s + Z_0G_{\pm})$. $e^{i\phi_s}$ is the phase accumulation inside the substrate[48].
- [20] Y. Xia, D. Qian, D. Hsieh, L. Wray, A. Pal, H. Lin, A. Bansil, D. Grauer, Y. Hor, R. Cava, et al., Nature Physics 5, 398 (2009).
- [21] N. Bansal, Y. S. Kim, M. Brahlek, E. Edrey, and S. Oh, Phys. Rev. Lett. **109**, 116804 (2012).
- [22] H. Hohler, Physica Status Solidi (b) 58, 91 (1973).
- [23] M. Bianchi, D. Guan, S. Bao, J. Mi, B. B. Iversen, P. D. C. King, and P. Hofmann, Nature Communications 1, 128 (2010).
- [24] In principle, the Zeeman effect and orbital effect should increase the scattering rate as well. Neverthless, Zeeman effect should be much smaller than a 50% increase at low field. Orbital effects

will lead to magneto-oscillations of transport lifetime (inverse scattering rate) above 3 T when $\omega_c \tau \ge 1$. (See SI section III for detailed calculation).

- [25] M. Orlita, C. Faugeras, G. Martinez, S. A. Studenikin, and P. J. Poole, EPL **92**, 37002 (2010).
- [26] M. Orlita, L. Z. Tan, M. Potemski, M. Sprinkle, C. Berger, W. A. de Heer, S. G. Louie, and G. Martinez, Phys. Rev. Lett. 108, 247401 (2012).
- [27] J. W. Allen and J. C. Mikkelsen, Phys. Rev. B 15, 2952 (1977).
- [28] $\Gamma_D^*(\omega)$ includes the renormalization effects of the lifetime as well as the mass. $\Gamma_D^*(\omega) = \frac{\Gamma_D(\omega)}{m_{RN}^*(\omega)/m_b} = \omega \frac{\text{Re}(G_D)}{\text{Im}(G_D)}$, which tells us the frequency-dependent scattering rate. Note that $\Gamma_D^*(\omega)$ does not depend on plasma frequency.
- [29] J. A. Sobota, S.-L. Yang, D. Leuenberger, A. F. Kemper, J. G. Analytis, I. R. Fisher, P. S. Kirchmann, T. P. Devereaux, and Z.-X. Shen, Phys. Rev. Lett. **113**, 157401 (2014).
- [30] X. Zhu, L. Santos, R. Sankar, S. Chikara, C. . Howard, F. C. Chou, C. Chamon, and M. El-Batanouny, Phys. Rev. Lett. 107, 186102 (2011).
- [31] D. Kim, Q. Li, P. Syers, N. P. Butch, J. Paglione, S. D. Sarma, and M. S. Fuhrer, Phys. Rev. Lett. **109**, 166801 (2012).
- [32] S. Giraud, A. Kundu, and R. Egger, Phys. Rev. B 85, 035441 (2012).
- [33] Ref. [30] reported the surface β phonon has frequency ~1.8 THz and surface spring constant is 75% of the bulk value. Therefore, the surface β phonon could be a softening bulk A_{1g} Raman active phonon (2.23 THz bulk value). The surface β phonon shows a Kohn anomaly at 2 k_f with ~ 0.75THz phonon frequency.
- [34] Phys. Rev. Lett. 108, 185501 (2012).
- [35] R. C. Hatch, M. Bianchi, D. Guan, S. Bao, J. Mi, B. B. Iversen, L. Nilsson, L. Hornekær, and P. Hofmann, Phys. Rev. B 83, 241303 (2011).
- [36] Z.-H. Pan, A. V. Fedorov, D. Gardner, Y. S. Lee, S. Chu, and T. Valla, Phys. Rev. Lett. **108**, 187001 (2012).
- [37] T. Kondo, Y. Nakashima, Y. Ota, Y. Ishida, W. Malaeb, K. Okazaki, S. Shin, M. Kriener, S. Sasaki, K. Segawa, et al., Phys. Rev. Lett. **110**, 217601 (2013).
- [38] R. Valdés Aguilar, L. Wu, A. V. Stier, L. S. Bilbro, M. Brahlek, N. Bansal, S. Oh, and N. P. Armitage, J. Appl. Phys. 113, 153702 (2013).
- [39] L. Wu, M. Brahlek, R. V. Aguilar, A. V. Stier, C. M. Morris, Y. Lubashevsky, L. S. Bilbro, N. Bansal, S. Oh, and N. P. Armitage, Nature Physics 9, 410 (2013), supplemetary Information.
- [40] Y. Cao, J. Waugh, X. Zhang, J. Luo, Q. Wang, T. Reber, S. Mo, Z. Xu, A. Yang, J. Schneeloch, et al., Nature Physics 9, 499 (2013).
- [41] Y. Zhang, K. He, C. Chang, C. Song, L. Wang, X. Chen, J. Jia, Z. Fang, X. Dai, W. Shan, et al., Nature Physics 6, 584 (2010).
- [42] C. H. Yang, F. M. Peeters, and W. Xu, Phys. Rev. B 82, 075401 (2010).
- [43] O. E. Raichev and F. T. Vasko, *Quantum Kinetic Theory and Applications* (Springer, 2005).
- [44] D. Culcer and S. Das Sarma, Phys. Rev. B 83, 245441 (2011);
 D. Culcer, E. H. Hwang, T. D. Stanescu, and S. Das Sarma, Phys. Rev. B 82, 155457 (2010).
- [45] T. Ando and Y. Uemura, J. Phys. Soc. Jpn. 36 959, (1974); T. Ando, J. Phys. Soc. Jpn. 36 1521 (1974); 37 622 (1974); 37 1233 (1974).
- [46] N. H. Shon and T. Ando, J. Phys. Soc. Jpn 67, 2421 (1998); Y.
 Zheng and T. Ando, Phys. Rev. B65, 245420 (2002).
- [47] I. Dmitriev, A. Mirlin, D. Polyakov, and M. Zudov, Reviews of Modern Physics 84, 1709 (2012).

136803 (2011).

- [48] J. N. Hancock, J. L. M. van Mechelen, A. B. Kuzmenko, D. van der Marel, C. Brüne, E. G. Novik, G. V. Astakhov, H. Buhmann, and L. W. Molenkamp, Phys. Rev. Lett. 107,